•	searcn	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/642,303	WAKAHARA, KEIJI	
Examiner	Art Unit	
Jason Benton	3747	

	SEARCHED		
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
123	41.15	10/30/2006	JB
123	41.05	10/30/2006	JB
123	41.02	10/30/2006	JB

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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